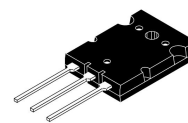


Features

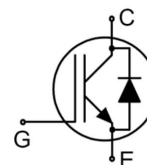
- Extremely Efficient Trench with Field Stop Technology
- $T_{Jmax} = 175^{\circ}C$
- Soft Fast Reverse Recovery Diode
- Optimized for High Speed Switching
- 10 μ s Short Circuit Capability



TO-264

Applications

- Solar Inverter
- UPS



Absolute Ratings ($T_c=25^{\circ}C$)

Parameter	Symbol	Value	Unit
Collector-Emmitter Voltage	V_{CES}	1200	V
Collector Current-continuous	I_c $T=25^{\circ}C$ $T=100^{\circ}C$	100	A
		50	A
Collector Current-pulse(note 1)	I_{CM}	200	A
Diode Continuous forward current	I_F $T=100^{\circ}C$	50	A
Diode Maximum Forward Current (Note 1)	I_{FM}	200	A
Gate-Emmitter Voltage	V_{GES}	± 20	V
Short Circuit Withstand Time	tsc	10	us
Power Dissipation($T_c=25^{\circ}C$)	P_D $T_c=25^{\circ}C$ $T_c=100^{\circ}C$	535	W
Power Dissipation($T_c=100^{\circ}C$)		267	W
Operating Temperature Range	T_J	-55~+175	$^{\circ}C$
Storage Temperature Range	T_{STG}	-55~+175	$^{\circ}C$
Maximum Lead Temperature for Soldering Purposes	T_L	260	$^{\circ}C$

Electrical Characteristic ($T_C=25^{\circ}C$ unless otherwise noted)

Parameter	Symbol	Tests conditions	Min	Typ	Max	Units
Off-Characteristics						
Collector-Emmitter Voltage	BV_{CES}	$I_c=500\mu A, V_{GE}=0V$	1200	-	-	V

Zero Gate Voltage Collector Current	I_{CES}	$V_{CE}=1200V, V_{GE}=0V$	-	-	0.1	mA	
		$T_C=175^{\circ}C$			2.0	mA	
Gate-body leakage current	I_{GES}	$V_{CE}=0V, V_{GE}=\pm 20V$	-	-	± 200	nA	
On-Characteristics							
Gate-Emmitter Threshold Voltage	$V_{GE(th)}$	$V_{CE}=V_{GE}, I_C=250\mu A$	4.5	5.5	6.5	V	
Collector-Emmitter saturation Voltage	V_{CESAT}	$V_{GE}=15V, I_C=50A, V_{GE}=15V, I_C=50A, T_J=175^{\circ}C$	-	2.20	2.40	V	
				2.60			
Dynamic Characteristics							
Input capacitance	C_{ies}	$V_{CE}=20V, V_{GE}=0V, f=1.0MHz, T_C=25^{\circ}C$	-	7383	-	pF	
Output capacitance	C_{oes}		-	233	-	pF	
Reverse transfer capacitance	C_{res}		-	139	-	pF	
Total Gate Charge	Q_g	$V_{CE}=600V, I_C=50A, V_{GE}=15V, T_C=25^{\circ}C$	-	311	-	nC	
Gate to emitter charge	Q_{ge}		-	64	-		
Gate to collector charge	Q_{gc}		-	155	-		
Switching Characteristics							
Turn-On delay time	$t_d(on)$	$V_{CC}=600V, I_C=50A, R_G=10\Omega, V_{GE}=15V$ Inductive load $T_C=25^{\circ}C$	-	118	-	ns	
Turn-On rise time	t_r		-	48	-	ns	
Turn-off delay time	$t_d(off)$		-	282	-	ns	
Turn-off Fall time	t_f		-	113	-	ns	
Turn-on switching loss	E_{on}		-	4.40	-	mJ	
Turn-off switching loss	E_{off}		-	1.40	-	mJ	
Total switching loss	E_{ts}		-	5.80	-	mJ	
Turn-On delay time	$t_d(on)$		$V_{CC}=600V, I_C=50A, R_G=10\Omega, V_{GE}=15V$ Inductive load $T_C=175^{\circ}C$	-	114	-	ns
Turn-On rise time	t_r			-	49	-	ns
Turn-off delay time	$t_d(off)$			-	298	-	ns
Turn-off Fall time	t_f	-		243	-	ns	
Turn-on switching loss	E_{on}	-		5.65	-	mJ	
Turn-off switching loss	E_{off}	-		3.26	-	mJ	
Total switching loss	E_{ts}	-		8.91	-	mJ	
Anti-Paraller Diode Characteristics and Maximum Ratings							
Diode Forward Voltage	V_F	$V_{GE}=0V, I_F=50A.$	-	2.00	2.60	V	
		$T_J=175^{\circ}C$		2.55			

Diode Reverse recovery time	t_{rr}	$V_R=400V, I_F=50A$ $di_F/dt=200A/us$ $T_J=25^\circ C$	-	256	-	ns
Reverse recovery charge	Q_{rr}		-	2.7	-	μC
Diode Reverse recovery Current	I_{rrm}		-	19	-	A
Diode Reverse recovery time	t_{rr}	$V_R=400V, I_F=50A$ $di_F/dt=200A/us$ $T_J=175^\circ C$	-	400	-	ns
Reverse recovery charge	Q_{rr}		-	5.75	-	μC
Diode Reverse recovery Current	I_{rrm}		-	27	-	A

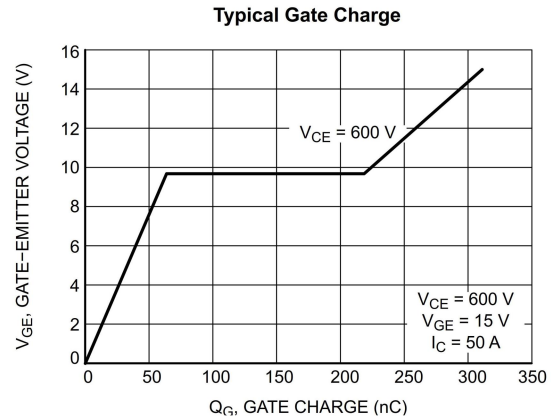
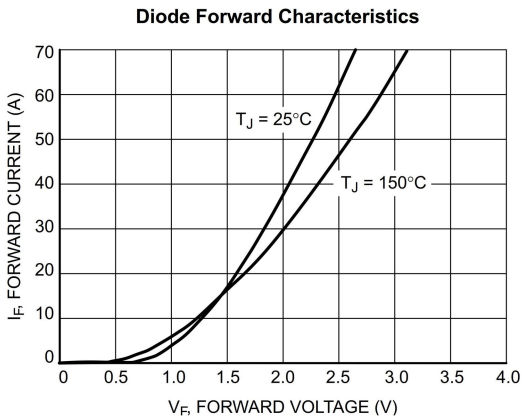
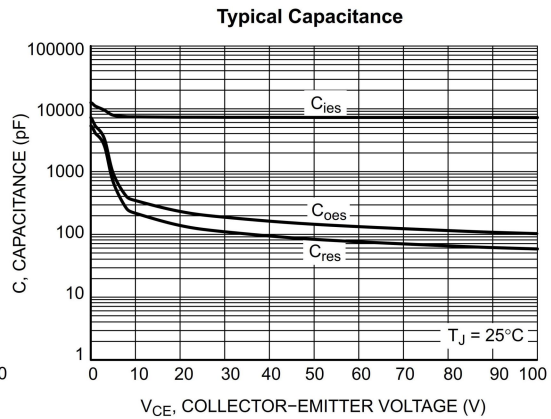
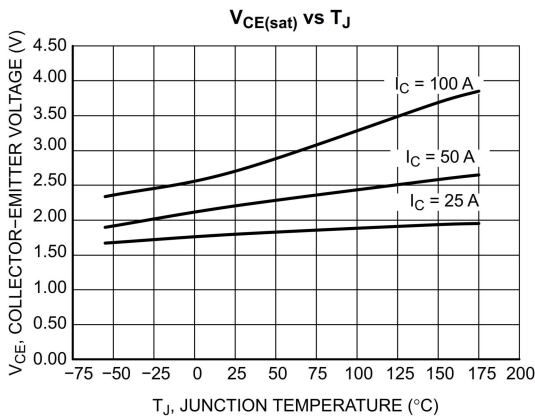
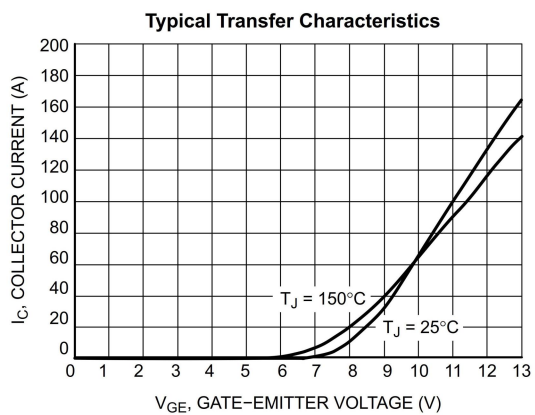
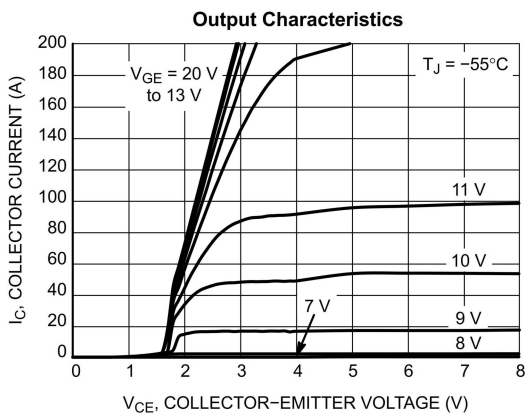
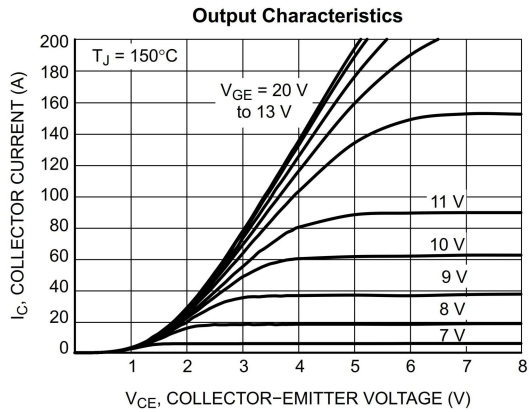
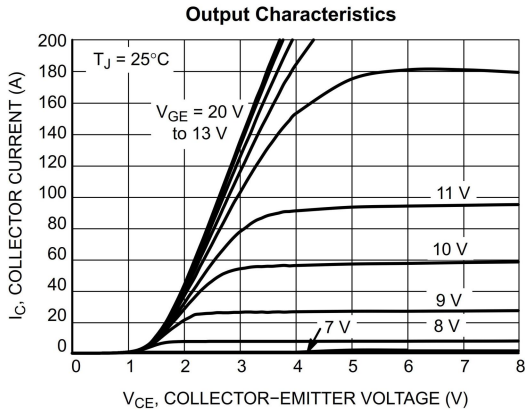
Thermal Characteristics

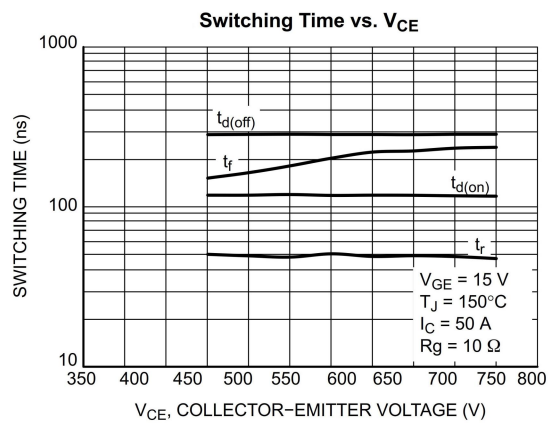
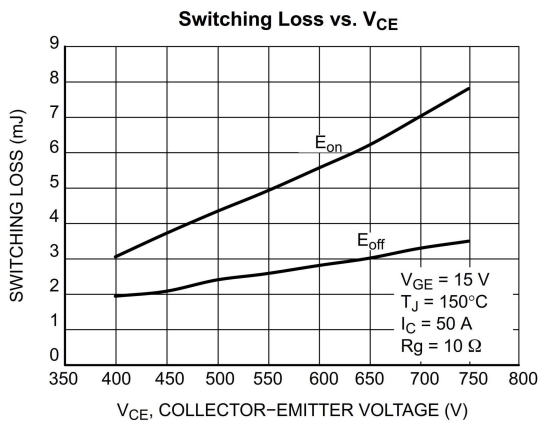
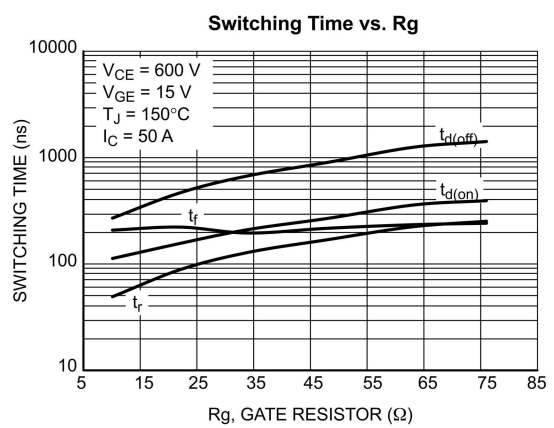
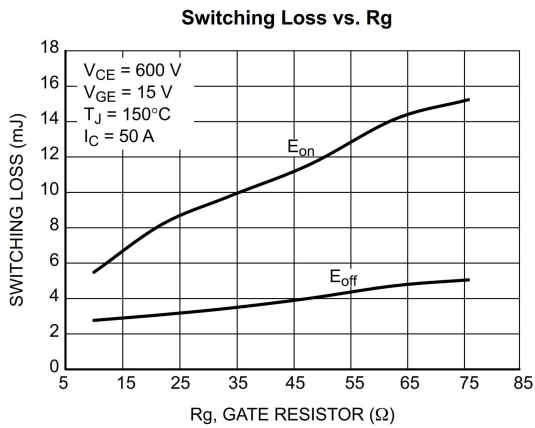
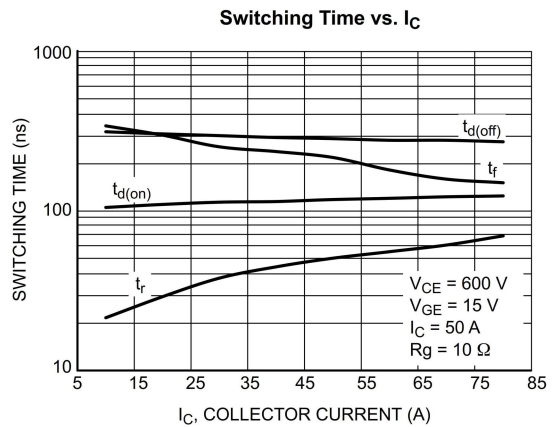
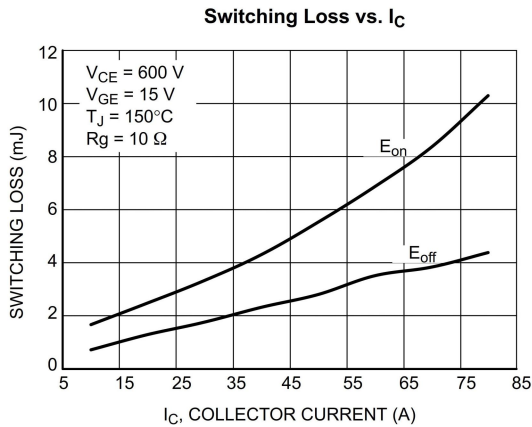
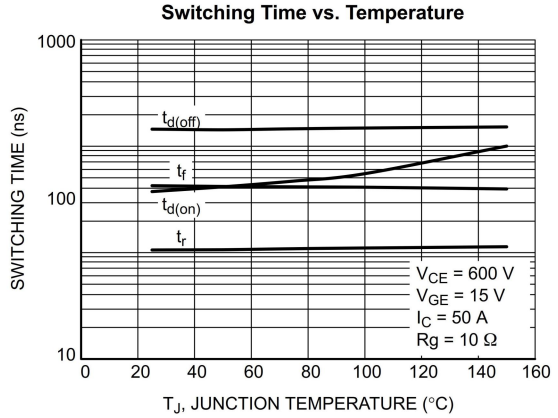
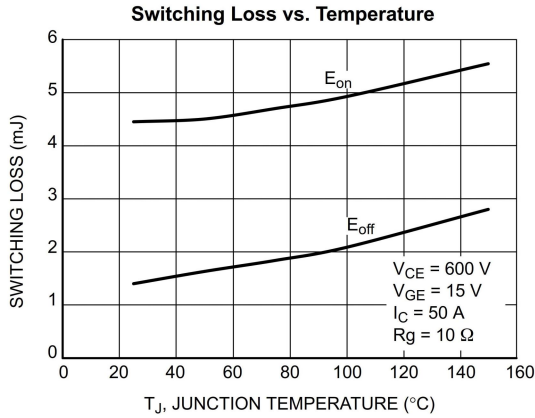
Symbol	Parameter	Max	Units
$R_{th\ j-c}$	Thermal Resistance, Junction to case for IGBT	0.28	$^\circ C/W$
$R_{th\ j-c}$	Thermal Resistance, Junction to case for Diode	0.5	$^\circ C/W$
$R_{th\ j-a}$	Thermal Resistance, Junction to Ambient	40	$^\circ C/W$

Notes:

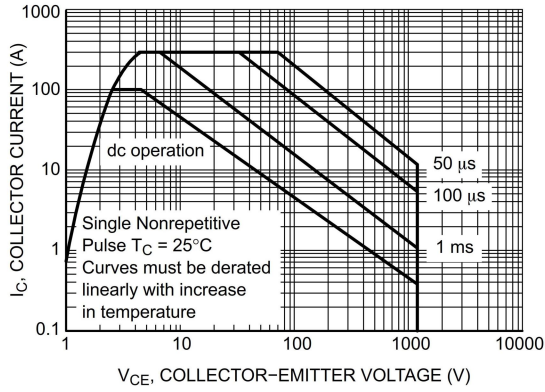
1: . Repetitive Rating: Pulse width limited by maximum junction temperature

Electrical Characteristics (curves)

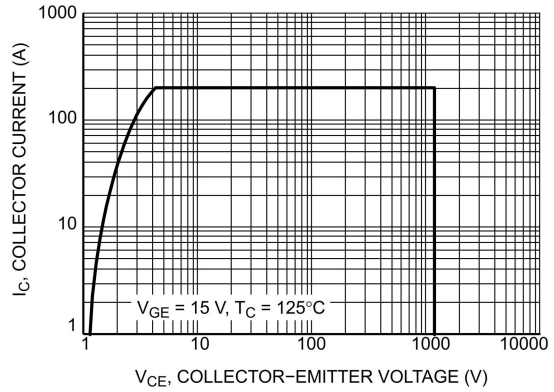




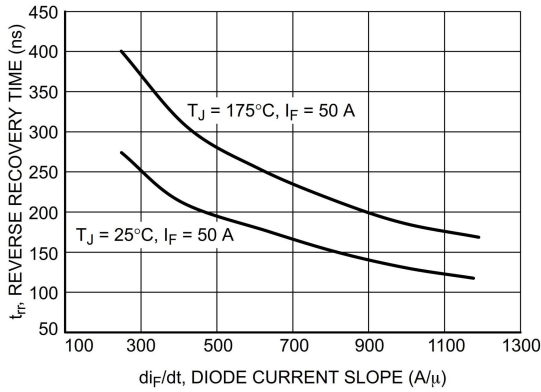
Safe Operating Area



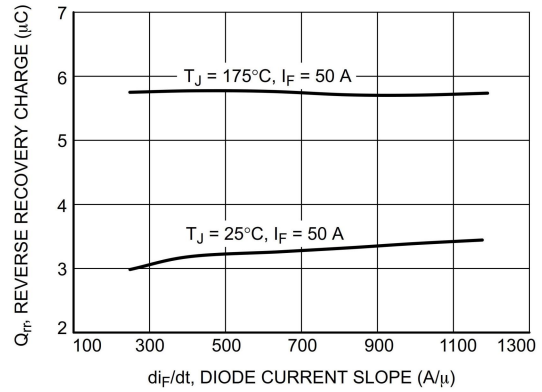
Reverse Bias Safe Operating Area



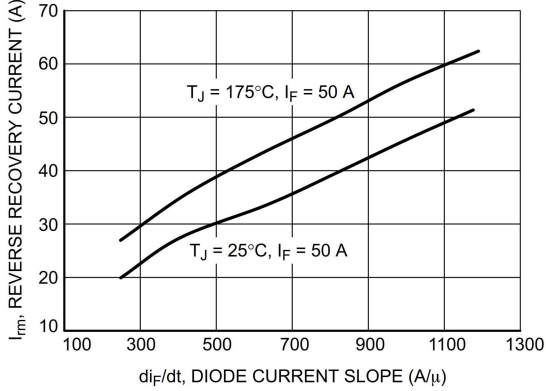
t_{rr} vs. di_F/dt ($V_R = 400\text{ V}$)



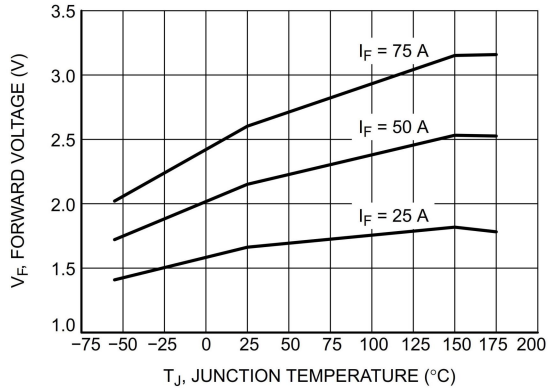
Q_{rr} vs. di_F/dt ($V_R = 400\text{ V}$)



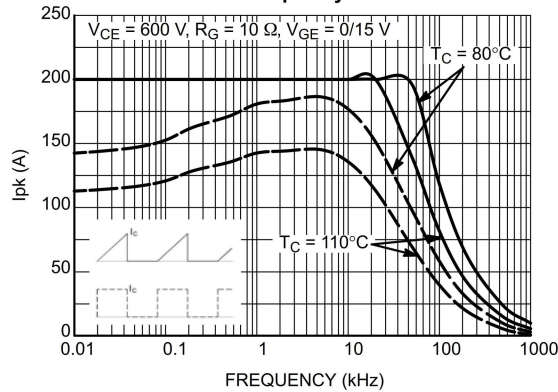
I_{rm} vs. di_F/dt ($V_R = 400\text{ V}$)

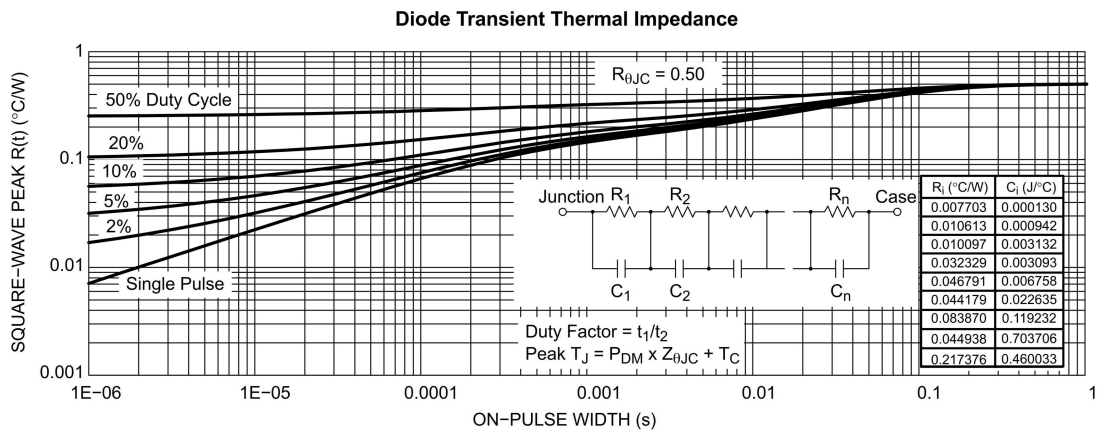
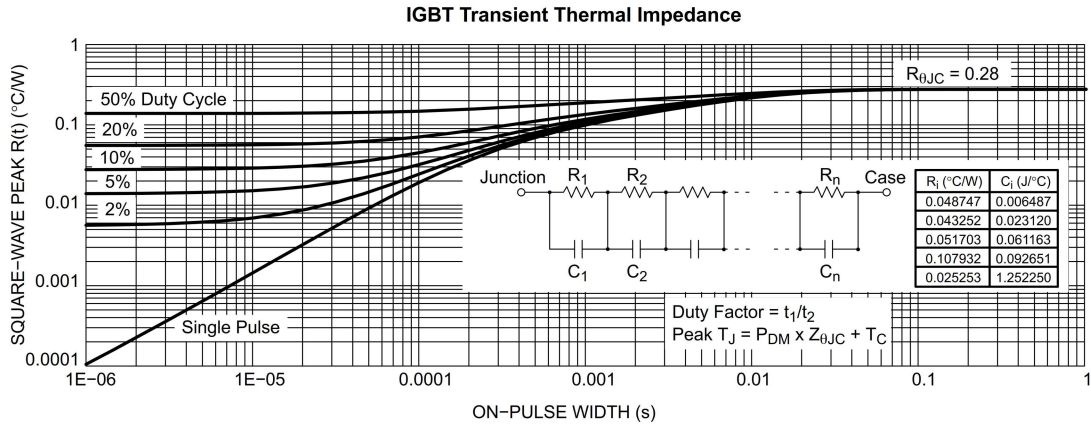


V_F vs. T_J

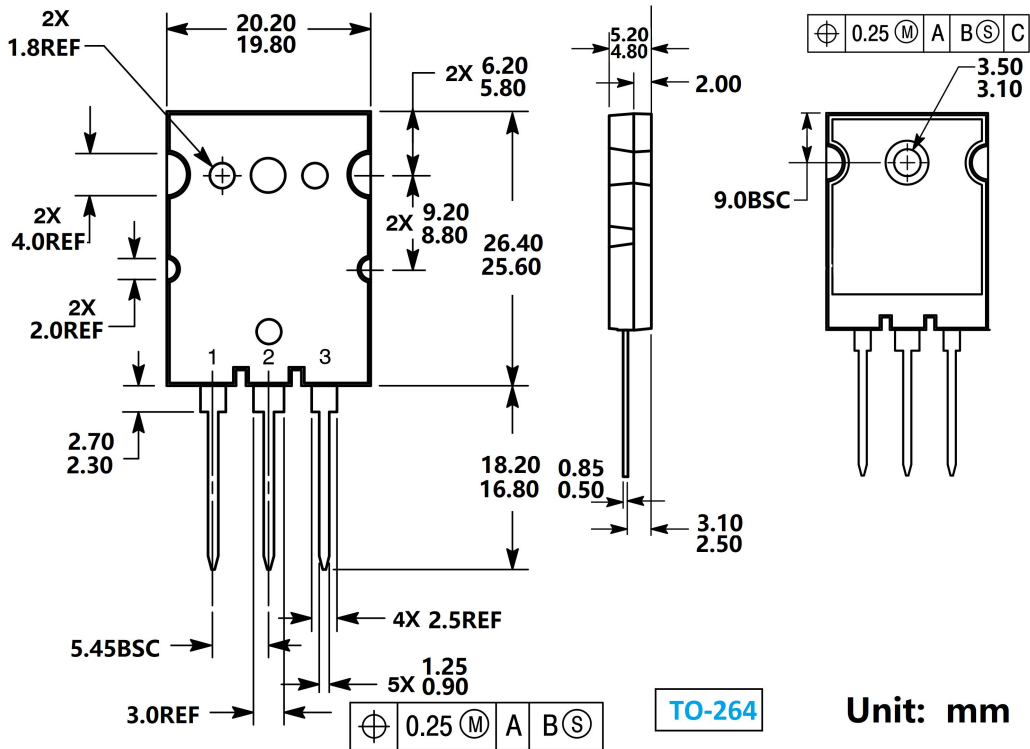


Collector Current vs. Switching Frequency





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